



I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on November 6, 2003

William R. Allen, Reg. No. 48,389

William R. Allen, Reg. No. 40,309

Date

Applicants:

Abdul Wahid Khan et al.

Serial No.:

10/629,053

Filed:

July 29, 2003

Examiner:

Unknown

Group Art Unit:

1743

Confirmation No.:

5911

For:

METHOD OF MAKING A MULTI-WELL TEST PLATE HAVING

ADHESIVELY SECURED TRANSPARENT BOTTOM PANEL

Atty. Docket No.:

NAC-96DV

Cincinnati, Ohio 45202

November 6, 2003

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

INFORMATION DISCLOSURE STATEMENT

In accordance with the duty of candor and good faith imposed by 37 C.F.R. §1.56 and means of complying therewith according to 37 C.F.R. §\$1.97 and 1.98, the references listed on the attached Form PTO-1449 are called to the attention of the Examiner in connection with the above-identified patent application. Copies of the certain of the cited references have already been supplied in connection with U.S.

Patent Application Ser. No. 09/427,235 (now abandoned). The present application is a divisional of Serial No. 09/427,235 and claims the benefit thereof under 35 U.S.C. § 120. Therefore, under 37 C.F.R. § 1.98(d) copies of the cited references need not be provided herewith. If additional copies of these references are desired, please contact the undersigned and they will be forwarded immediately.

The Examiner is urged to consider all of the cited documents and to make an independent evaluation of the teachings and materiality of each.

Applicants do not believe that any fees are due in connection with this submission. However, if such petition is due or any fees are necessary, the Commissioner may consider this to be a request for such and charge any necessary fees to deposit account 23-3000.

Respectfully submitted,

WOOD, HERRON & EVANS, L.L.P.

William R. Allen

Reg. No. 48,389

2700 Carew Tower 441 Vine Street Cincinnati, OH 45202 (513) 241-2324 K:\NAC\96DV\ids.wpd

U.S. DEPARTMENT OF COMMERCE ATTY. DOCKET NO. SERIAL NO. SUBSTITUTEFORM PTO-1449 PATENT AND TRADEMARK OFFICE NAC/96DV 10/629,053 (MODIFIED) INFORMATION DISCLOSURE APPLICANT NOV 1 0 2003 STATEMENT BY APPLICANT Abdul Wahid Khan et al. **GROUP FILING DATE** (Use several sheets if necessary) July 29, 2003 1743 U.S. PATENT DOCUMENTS FILING DATE ISSUE EXAMINER IF APPROPRIATE PATENT NUMBER **CLASS SUBCLASS** , DATE PATENTEE INITIAL 7/1973 McCormick 195 139 A.A 5 0 9 A.B 4 0 0 4 1 5 0 1/1977 Natelson 250 328 6 5 5 0 2/28/78 Thurn et al. 106 288 5/26/76 4 0 A.C 5/1979 7 9 Thorne 422 99 A.D 4 1 5 4 5 2/1981 5 White 356 246 2 9 A.E 4 5 1 6/1981 422 71 A.F 2 6 2 5 9 Eibl et al. 4/7/80 2 8 4 5 4 2 8/18/81 Boyce et al. 260 27 A.G 2 11/1981 435 6 4 3 0 5 3 Halmann et al. A.H 5/1983 435 33 3 8 5 de Zabala et al. A.I 4 1 4 2 4 0 6 7 1/1984 Tarasenko et al. 55 16 A.J 4 2/1984 356 246 A.K 4 3 3 0 Suovaniemi FOREIGN PATENTS OR PUBLISHED FOREIGN PATENT APPLICATIONS **PUBLICATION** TRANSLATION COUNTRY OR **DOCUMENT** (YES/NO) **SUBCLASS** PATENT OFFICE **CLASS** NUMBER DATE ΕP 0571661 A1 12/1993 A.L 7/1996 EP 0723812 A1 A.M **PCT** WO 98/42442 10/1998 A.N A.O A.P A.Q OTHER DOCUMENTS (Including Author, Title, Date, Place of Publication) Nalge Nunc International, Evolving Excellence for In Situ Culture & Analysis, Brochure, undated A.R Nalge Nunc International, Introducing Lab-Tex II The Next Generation, Brochure, undated A.S Nalge Nunc International, <u>Lab-Tek II Chambered Coverglass Gear Up for High-Power Inverted Methods...</u>, Brochure, A.T undated DATE CONSIDERED **EXAMINER**

EXAMINER: Initial if citation considered, whether or not in conformance. Draw line through citation only if not in conformance and not considered.

Include a copy of this form with next communication to applicant.

Sheet 2(B) of 4 U.S. DEPARTMENT OF COMMERCE ATTY, DOCKET NO. SERIAL NO. SUBSTITUTE FORM PTO-1449 PATENT AND TRADEMARK OFFICE NAC/96DV 10/629,053 (MODIED) **APPLICANT** INFORMATION DISCLOSURE 0 2003 Abdul Wahid Khan et al. STATEMENT BY APPLICANT **GROUP** FILING DATE (Use several sheets if necessary) July 29, 2003 1743 **U.S. PATENT DOCUMENTS** FILING DATE ISSUE **EXAMINER** IF APPROPRIATE PATENT NUMBER DATE **CLASS SUBCLASS PATENTEE** INITIAL 8/1984 422 102 B.A 6 8 Chen et al. 4 4 9 3 8 1 5 1/1985 Fernwood et al. 422 101 B.B 10/1985 422 102 5 5 9 5 B.C 4 8 Dopatka 2 3/1987 514 26 B.D 4 6 5 5 5 3 Hagmann et al. 1/1988 47 56 B.E 4 7 2 0 9 3 5 Rogers et al. B.F 4 7 3 5 7 7 8 4/1988 Maruyama et al. 422 102 1 6 5/1988 356 246 4 9 Humphries et al. B.G 5 9/1988 422 104 B.H 7 7 0 8 6 Uthemann et al. 8 5/1989 Matkovich et al. 356 246 4 8 2 3 8 6 B.I 10/3/89 427 387 11/6/87 5 0 Merz et al. B.J 4 8 7 1 9 9 8 2 8/1990 Manns 156 73.1 B.K 4 4 4 FOREIGN PATENTS OR PUBLISHED FOREIGN PATENT APPLICATIONS TRANSLATION **PUBLICATION** COUNTRY OR DOCUMENT **SUBCLASS** (YES/NO) PATENT OFFICE **CLASS** NUMBER DATE B.L B.M B.N B.O B.P B.Q OTHER DOCUMENTS (Including Author, Title, Date, Place of Publication) Nalge Nunc International, Nunc™ Products Laboratory Products for Cell Culture, Molecular Biology, Cyropreservation and B.R Immunology, Catalog, 1998-1999

EXAMINER: Initial if citation considered, whether or not in conformance. Draw line through citation only if not in conformance <u>and</u> not considered. Include a copy of this form with next communication to applicant.

B.S B.T

EXAMINER

U.S. Patent Application Publication Number US 2003/O031829; Applicant: Tanner et al.; Published: 2/13/O3

DATE CONSIDERED

SUBSTAUTE (MODIFIED)	FORME	TO.	-144	1 9				_		ENT OF COMMERCE TRADEMARK OFFICE	ATTY. DOCKET NO. NAC/96DV			SERIAL NO. 10/629,053		
NCV 1	0 2003	(1) RO11						ISCL APP		APPLICANT Abdul Wahid Khan et al.						
(37 CFR 1:98)	b))(b)	<i>'</i>	Use	e se	vera	al sh	eet	s if ne	ecessary)					GROU 1743	GROUP 1743	
U.S. PATENT DOCUMENTS																
EXAMINER INITIAL			PA ⁻	TEN	IT N	IUM	IBEI	₹	ISSUE DATE	PATENTEE	_	CLASS	SUBC	LASS	FILING DATE IF APPROPRIATE	
	C.A	4 9 5 6 1 5 0					5	0	9/1990	Henry		422	102			
	C.B	4	9	7	3	7	4	2	11/1990	Ohsaka et al.		560	184			
	C.C	5	0	4	3	5	8	1	8/1991	Joss		250	328			
	C.D	5	0	4	7	2	1	5	9/1991	Manns	-	422	101			
	C.E	5 0 8 2 6 2 8						8	1/1992	Andreotti et al.	422	82.08				
	C.F	5	+++++							Goodwin, Jr.	-	435	29		8/20/92	
	C.G	5	3	1	9	4	3	6	6/1994	Manns et al.		356	246			
	C.H	5	4	8	7	8	7	2	1/1996	Hafeman et al.		422	102			
	C.I	5	5	0	8	1	9	7	4/1996	Hansen et al.		435	285.1			
	C.J	5	5	4	0	9	7	8	7/1996	Schrenk		428	212			
	C.K	5	5	7	1	7	2	1	11/1996	Turner		435	305.1			
FOREIGN PATENTS OR PUBLISHED FOREIGN PATENT APPLICATIONS																
DOCUMENT PUBLICATION NUMBER DATE										COUNTRY OF		CLASS	SUBCL	ASS	TRANSLATION (YES/NO)	
	C.L															
	C.M															
	C.N															
	C.O															
	C.P															
	C.Q															
					0	THE	R [ocu	JMENTS (Incl	uding Author, Title, Date	e, Place	of Publication	n)		•	
	C.R															
	c.s															
	C.T															
EXAMINER DATE CONSIDERED																
EXAMINER: Initial if citation considered, whether or not in conformance. Draw line through citation only if not in conformance and not considered. Include a copy of this form with next communication to applicant.																

SUBSTITUTE (MODIFIED)	FORM F	OTO	-144	49						ENT OF COMMERCE RADEMARK OFFICE	ATTY. DOCKET NO. NAC/96DV			SERIAL NO. 10/629,053		
NOV 1	0 2003	1							OSURE LICANT		APPLICANT Abdul Wahid Khan et al.					
(37 CFR 1.98	(b))	ij	Use	e se	vera	al st	neet	s if ne	ecessary)		FILING DATE July 29, 2003			GROUP 1743		
237	1								U.S. F	PATENT DOCUMENTS						
EXAMINER INITIAL			PA ⁻	TEN	NT N	IUM	BE	₹	ISSUE DATE	PATENTEE		CLASS	SUBC	CLASS	FILING DATE IF APPROPRIATE	
	D.A	5 5 8 0 5 2 8 12/19						8	12/1996	Demers	422	100				
	D.B	5	7	3	6	1	0	6	4/1998	Ishiguro et al.		422	131			
	D.C	5	8	5	8	3	0	9	1/1999	Mathus et al.		422	102			
	D.D	5	8	5	8	7	7	0	1/12/99	Perlman		435	305.3		9/30/97	
	D.E	6	6 1 7 1 7 8 0 1/9/O1 Pham et al.							Pham et al.		435	4		2/24/98	
	D.F	6	4	5	8	2	7	5	10/1/O2	Shukla et al.		210	321.6		6/5/O0	
	D.G							· · · ·								
	D.H			T	Γ	Γ					-					
	D.I			Γ		Γ										
	D.J															
	D.K			Γ							-					
FOREIGN PATENTS OR PUBLISHED FOREIGN PATENT APPLICATIONS																
	DOCUMENT NUMBER								UBLICATION DATE		COUNTRY OR PATENT OFFICE C		SUBCLASS		TRANSLATION (YES/NO)	
-	D.L															
	D.M															
	D.N			•												
, C	D.O															
	D.P															
	D.Q															
					0	THE	R	ocu	JMENTS (Incl	uding Author, Title, Date	e, Place	of Publication	٦)			
	D.R									-						
	D.S															
	D.T															
EXAMINER										DATE CONS	DATE CONSIDERED					
EXAMINER: I	nitial if cit	tatic	n co	onsi	ider	ed,	whe	ther o	or not in confo	rmance. Drawline thro	ugh citati	on only if no	t in confo	rmance	and not considered.	